

MCR221-5, MCR221-7, MCR221-9

SILICON CONTROLLED RECTIFIERS

FEATURES

- Available as "HR" (high reliability) screened per MIL-PRF-19500, JANTX level. Add "HR" suffix to base part number.
- Available as non-RoHS (Sn/Pb plating), standard, and as RoHS by adding "-PBF" suffix.

MAXIMUM RATINGS

Rating	Symbol	Value	Unit
Peak repetitive forward and reverse off-state voltage ⁽¹⁾ MCR221-5 MCR221-7 MCR221-9	V_{DRM} V_{RRM}	300 500 700	Volts
On-state RMS current (180° conduction angles), $T_C = 90^\circ\text{C}$	$I_{T(RMS)}$	16	Amps
Average on-state current	$I_{T(AV)}$	10	Amps
Peak non-repetitive surge current (1/2 cycle, sine wave 60Hz, $T_J = 125^\circ\text{C}$)	I_{TSM}	160	Amps
Circuit fusing ($t = 8.3\text{ms}$, $T_J = -40$ to $+125^\circ\text{C}$)	I^2t	100	A^2s
Forward peak gate power	P_{GM}	20	Watts
Forward average gate power	$P_{G(AV)}$	0.5	Watts
Forward peak gate current	I_{GM}	2.0	Amps
Operating junction temperature range	T_J	-40 to 125	$^\circ\text{C}$
Storage temperature range	T_{stg}	-40 to 150	$^\circ\text{C}$

THERMAL CHARACTERISTICS

Characteristic	Symbol	Max	Unit
Thermal resistance, junction to case	$R_{\theta JC}$	1.5	$^\circ\text{C/W}$

ELECTRICAL CHARACTERISTICS ($T_J = 25^\circ\text{C}$ unless otherwise specified)

Characteristic		Symbol	Min	Typ	Max	Unit
OFF CHARACTERISTICS						
Peak repetitive forward or reverse blocking current ($V_{AK} = \text{rated } V_{DRM} \text{ or } V_{RRM}, \text{ gate open}$)	$T_J = 25^\circ\text{C}$ $T_J = 125^\circ\text{C}$	I_{DRM}, I_{RRM}	- -	- -	10 2.0	μA mA
ON CHARACTERISTICS						
Peak forward on-state voltage ($I_{TM} = 32\text{A}$ peak, pulse width $\leq 1\text{ms}$, duty cycle $\leq 2\%$)		V_{TM}	-	-	1.7	Volts
Gate trigger current (continuous dc) ($V_D = 12\text{Vdc}$, $R_L = 50\text{ohms}$)		I_{GT}	-	5.0	30	mA
Gate trigger voltage (continuous dc) ($V_D = 12\text{Vdc}$, $R_L = 50\text{ohms}$)	$T_C = 25^\circ\text{C}$ $T_C = -40^\circ\text{C}$	V_{GT}	- -	0.7 -	1.5 2.5	Volts
Gate non-trigger voltage ($V_D = \text{Rated } V_{DRM}, R_L = 50\text{ohms}$)	$T_C = 125^\circ\text{C}$	V_{GD}	0.2	-	-	Volts

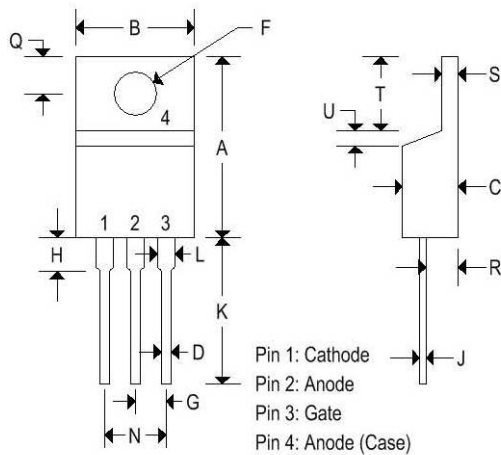
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ON CHARACTERISTICS						
Holding current ($V_D = 12\text{Vdc}$)	$T_C = 25^\circ\text{C}$ $T_C = -40^\circ\text{C}$	I_H	- -	6 -	40 60	mA
Turn-on time ($I_{TM} = 16\text{A}$, $I_{GT} = 40\text{mAdc}$, $V_D = \text{rated } V_{DRM}$)		t_{gt}	-	1.0	-	μs
Turn-off time ($I_{TM} = 16\text{A}$, $I_R = 16\text{A}$, $V_D = \text{rated } V_{DRM}$)	$T_C = 25^\circ\text{C}$ $T_J = 125^\circ\text{C}$	t_q	- -	15 35	- -	μs
DYNAMIC CHARACTERISTICS						
Critical rate of rise of off state voltage ($V_D = \text{rated } V_{DRM}$, exponential waveform)	$T_J = 125^\circ\text{C}$	dv/dt	-	50	-	$\text{V}/\mu\text{s}$

MECHANICAL CHARACTERISTICS

Case:	TO-220AB
Marking:	Body painted, alpha-numeric
Pin out:	See below



	TO-220AB			
	Inches		Millimeters	
	Min	Max	Min	Max
A	0.575	0.620	14.600	15.750
B	0.380	0.405	9.650	10.290
C	0.160	0.190	4.060	4.820
D	0.025	0.035	0.640	0.890
F	0.142	0.147	3.610	3.730
G	0.095	0.105	2.410	2.670
H	0.110	0.155	2.790	3.930
J	0.014	0.022	0.360	0.560
K	0.500	0.562	12.700	14.270
L	0.045	0.055	1.140	1.390
N	0.190	0.210	4.830	5.330
Q	0.100	0.120	2.540	3.040
R	0.080	0.110	2.040	2.790
S	0.045	0.055	1.140	1.390
T	0.235	0.255	5.970	6.480
U	-	0.050	-	1.270
V	0.045	-	1.140	-
Z	-	0.080	-	2.030

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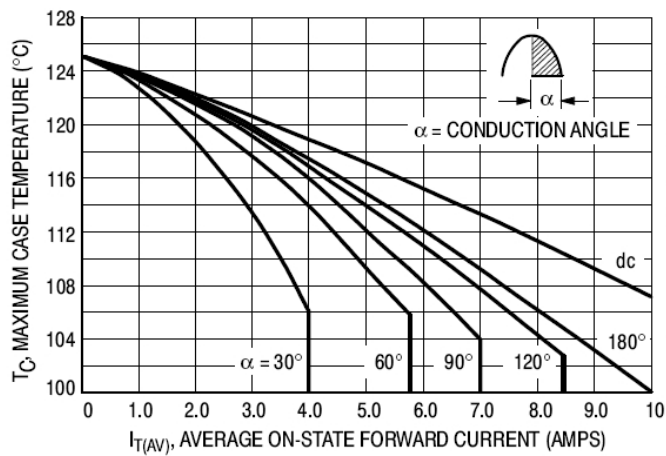
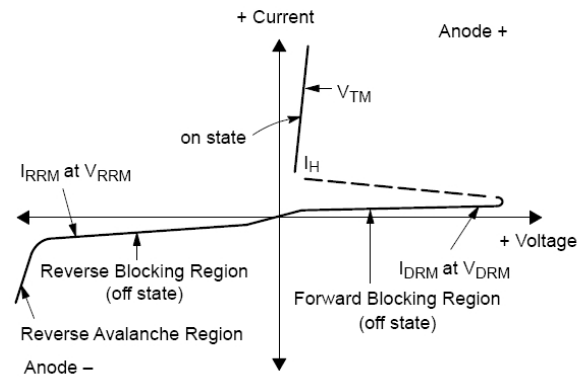


Figure 1. Average Current Derating

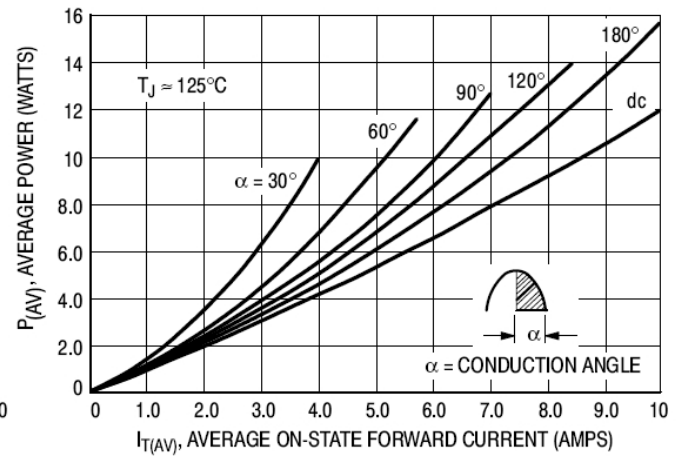


Figure 2. Maximum On-State Power Dissipation

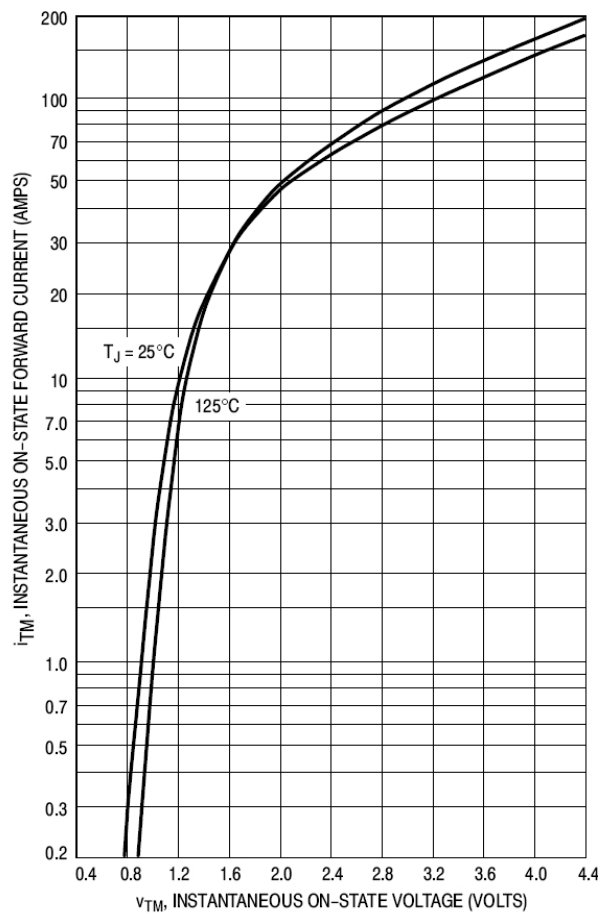


Figure 3. On-State Characteristics

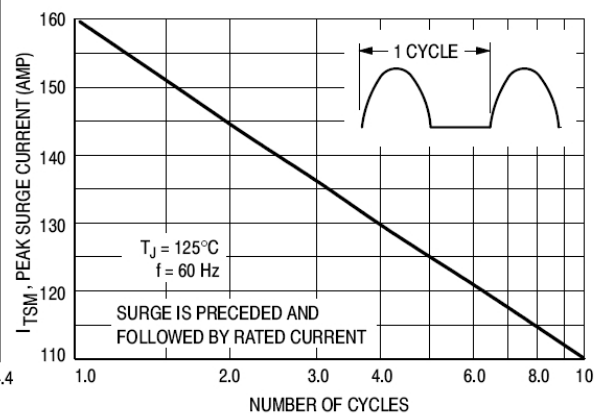


Figure 4. Maximum Non-Repetitive Surge Current

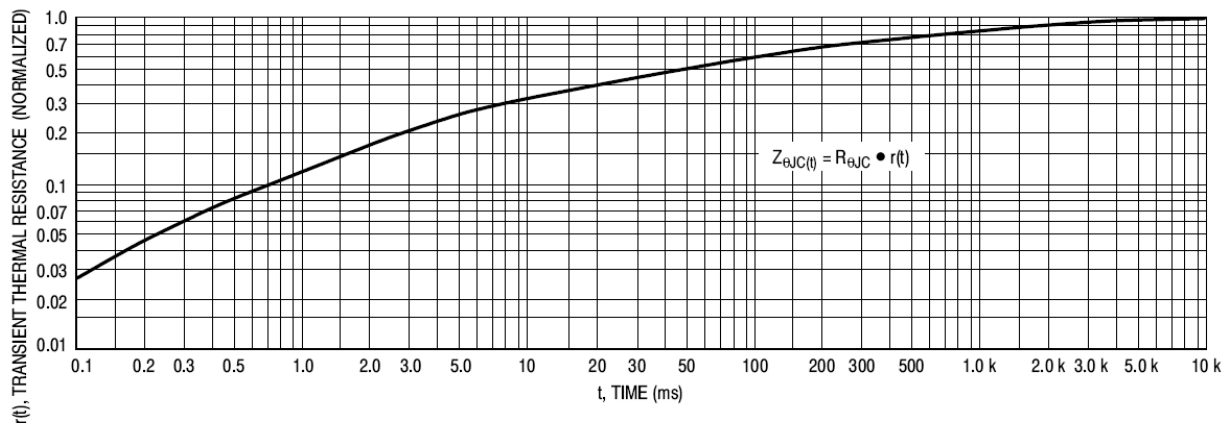


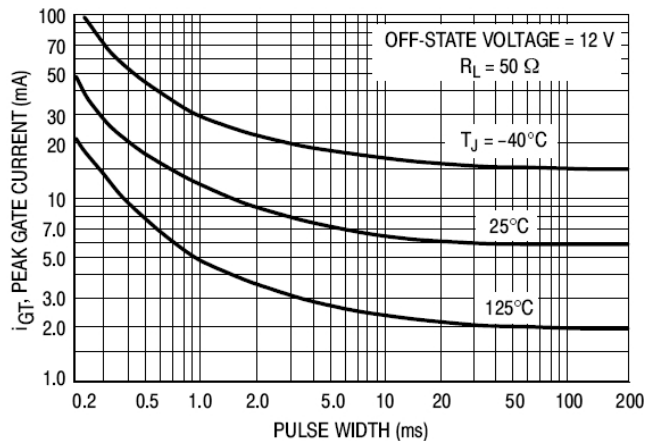
Figure 5. Thermal Response



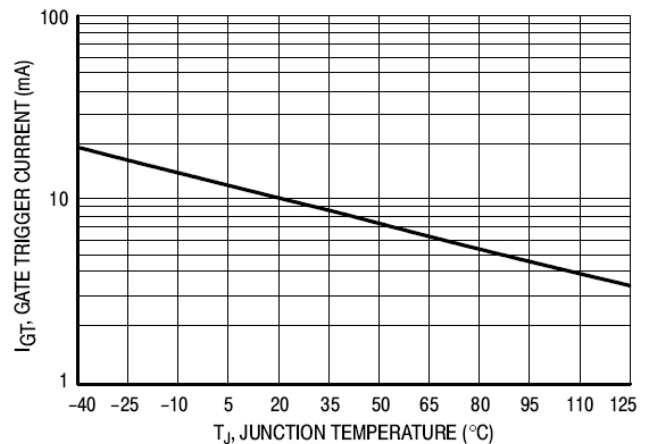
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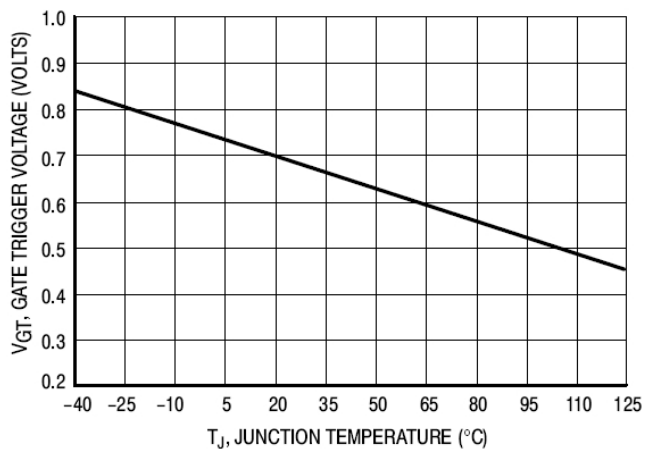
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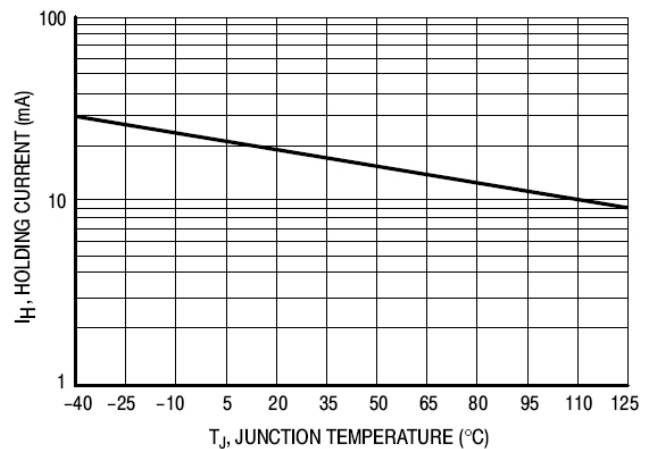
**Figure 6. Typical Gate Trigger Current
versus Pulse Width**



**Figure 7. Typical Gate Trigger Current
versus Junction Temperature**



**Figure 8. Typical Gate Trigger Voltage
versus Junction Temperature**



**Figure 9. Typical Holding Current
versus Junction Temperature**